TOSHIBA 2SK1828

TOSHIBA FIELD EFFECT TRANSISTOR SILICON N CHANNEL MOS TYPE

2 S K 1 8 2 8

HIGH SPEED SWITCHING APPLICATIONS

ANALOG SWITCH APPLICATIONS

2.5V Gate Drive

Low Threshold Voltage: $V_{th} = 0.5 \sim 1.5 \text{V}$

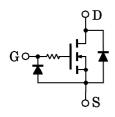
High Speed

Enhanncement-Mode

Small Package

EQUIVALENT CIRCUIT







This transistor is electrostatic sensitive device. Please handle with caution.

Unit in mm **GATE** SOURCE DRAIN S-MINI **JEDEC** TO-236MOD **EIAJ** SC-59

Weight: 0.012g (Typ.)

2-3F1F

TOSHIBA

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT	
Drain-Source Voltage	$v_{ m DS}$	20	V	
Gate-Source Voltage	v_{GSS}	10	V	
DC Drain Current	$I_{\mathbf{D}}$	50	mA	
Drain Power Dissipation	P_{D}	200	mW	
Channel Temperature	$\mathrm{T_{ch}}$	150	°C	
Storage Temperature Range	$\mathrm{T_{stg}}$	-55~150	°C	

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ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARAC	TERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gate Leakage Current		$I_{ ext{GSS}}$	$V_{GS}=10V, V_{DS}=0$	_	_	1	μ A
Drain-Source Breakdown Voltage		V _(BR) DSS	$I_{D} = 100 \mu A, V_{GS} = 0$	20	_	_	V
Drain Cut-off	Current	$I_{ m DSS}$	$V_{DS}=20V, V_{GS}=0$	_	_	1	μ A
Gate Threshole	d Voltage	v_{th}	$V_{ m DS}$ =3V, $I_{ m D}$ =0.1mA	0.5		1.5	V
Forward Transfer Admittance		$ Y_{fs} $	V_{DS} =3V, I_{D} =10mA	20	_	_	mS
Drain-Source ON Resistance		R _{DS} (ON)	$I_D=10$ mA, $V_{GS}=2.5$ V	_	20	40	Ω
Input Capacitance		$\mathrm{c}_{\mathrm{iss}}$	$V_{DS}=3V$, $V_{GS}=0$, $f=1MHz$	_	5.5	_	рF
Reverse Transfer Capacitance		C_{rss}	V_{DS} =3V, V_{GS} =0, f=1MHz	_	1.6	_	pF
Output Capacitance		C_{oss}	$V_{DS}=3V$, $V_{GS}=0$, $f=1MHz$	_	6.5	_	pF
Switching Time	Turn-on Time	$t_{ m on}$	V _{DD} =3V, I _D =10mA, V _{GS} =0~2.5V	_	0.14	_	μs
	Turn-off Time	$t_{ m off}$	V _{DD} =3V, I _D =10mA, V _{GS} =0~2.5V	_	0.14	_	μs

SWITCHING TIME TEST CIRCUIT

